

Search Notes

Application/Control No.

10/617,171

Examiner

Tianjie Chen

Applicant(s)/Patent under
Reexamination

JEONG, KI-TAG

Art Unit

2627

SEARCHED

Class	Subclass	Date	Examiner
Updated		12/3/2006	TJ

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR